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required to respond to a collection of information unless it displays a valid OMB control number. t of 1995, no tersons Application Number 10/734,999 Filing Date December 12, 2003 ۱L **FORM** First Named Inventor Eugene P. Marsh Art Unit (to be used for all correspondence after initial filing) Unknown Examiner Name Unknown Attorney Docket Number MI22-2461

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This collection of information is required by 37 CFR 1.5. The information is required to obtain or retain a benefit by the public which is to file (and by the USPTO to process) an application. Confidentiality is governed by 35 U.S.C. 122 and 37 CFR 1.14. This collection is estimated to 12 minutes to complete, including gathering, preparing, and submitting the completed application form to the USPTO. Time will vary depending upon the individual case. Any comments on the amount of time you require to complete this form and/or suggestions for reducing this burden, should be sent to the Chief Information Officer, U.S. Patent and Trademark Office, U.S. Department of Commerce, P.O. Box 1450, Alexandria, VA 22313-1450. DO NOT SEND FEES OR COMPLETED FORMS TO THIS ADDRESS SEND TO: Commissioner for Patents, P.O. Box 1450, Alexandria, VA 22313-1450.

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IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

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Apprication Serial No	10/734,999
Application Serial No.	December 12, 2003
Inventor	Eugene P. Marsh et al.
Assignee	
Group Art Unit	Unknown
Examiner	
Attorney's Docket No	MI22-2461

Title: Atomic Layer Deposition Methods

SUPPLEMENTAL INFORMATION DISCLOSURE STATEMENT

References -- See Attached Form PTO-1449

In compliance with 37 C.F.R. §§ 1.56, 1.97 and 1.98, your attention is directed to the United States patents and other references listed on the attached Form PTO-1449. Only copies of the foreign art are attached hereto. No admission is made regarding whether all the submitted references are prior art.

This Supplemental Information Disclosure Statement is being filed within three months of the filing date of the application or before the mailing of a first Office Action on the merits, whichever occurs last. Therefore, no fee is believed to be required.

Each item of information contained in the attached PTO-1449 was first cited in a communication from a foreign patent office in a counterpart foreign application not more than three months prior to the filing of this Supplemental Information Disclosure Statement. Therefore, no fee is believed to be required. However, in the event that a fee is required for filing this Supplemental Information Disclosure Statement, please charge the fee specified under 37

C.F.R. § 1.17(p) to Deposit Account No. 23-0925. Please credit Deposit Account No. 23-0925 with any overpayment of the above fee.

Respectfully submitted,

Dated: 1-12-09

Mark S. Matkin

Reg. No. 32,268

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ATTY. DOCKET NO. MI22-2461

SERIAL NO. 10/734,999

LIST OF ART CITED BY APPLICANT

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APPLICANT: Micron Technology, Inc.

FILING DATE December 12, 2003

GROUP Unknown

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	AA	5,879,459	03/1999	Gadgil et al.	118	715		
	AB	5,972,430	10/1999	DiMeo, Jr. et al.	427	255.32		
	AC	6,174,377 B1	01/2001	Doering et al.	118	729		
	AD	6,200,893 B1	03/2001	Sneh	438	685		
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	A)	01/27347 A1	04/2001	wo	16	44		
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	AL	01/29893 A1	04/2001	wo	21	768		
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	AA	6,475,276 B1	11/2002	Elers et al.	117	84		• •
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	Al	2002/0086111 A1	07/2002	Byun et al.	427	255.394		
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	AA	2002/0108714 A1	08/2002	Doering et al.	156	345.51		
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